

Mitigating Phonon-mediated Quasiparticle Poisoning of Superconducting Qubits

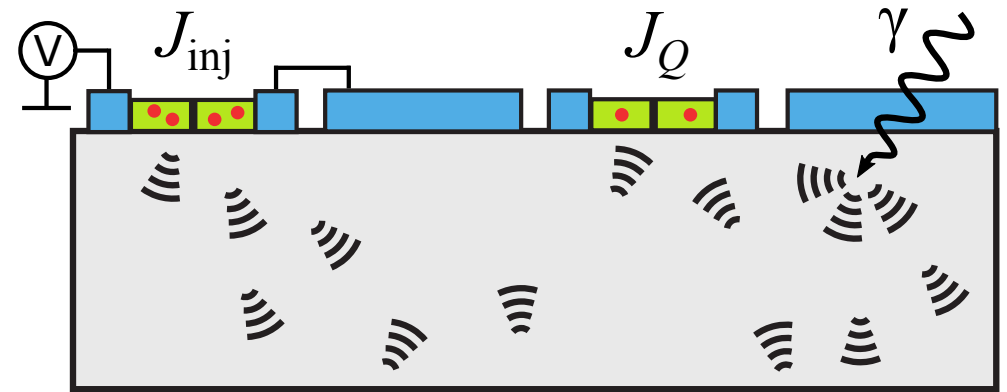
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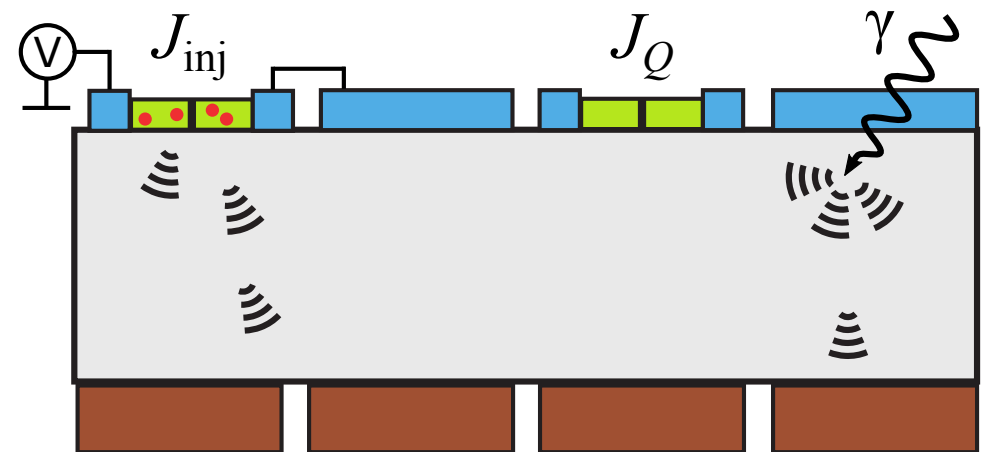
Radiation Impact on Superconducting Qubits
Fermilab
May 30, 2024

Mitigating & characterizing phonon-mediated QP poisoning

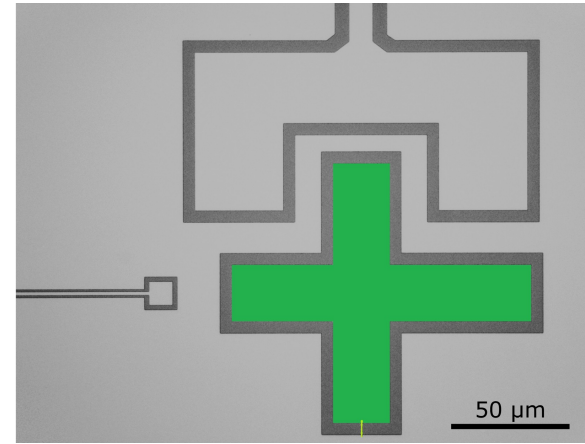
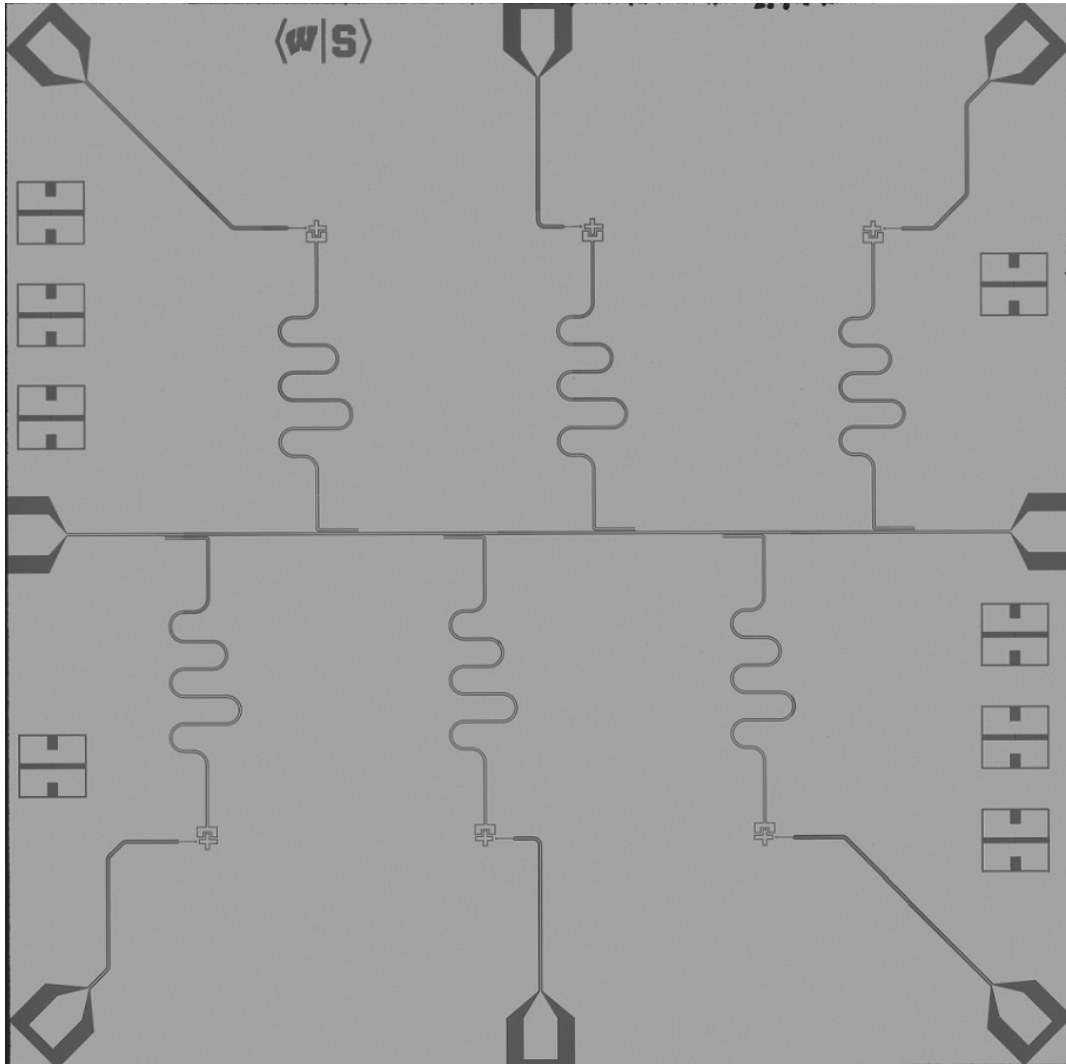
- Qubit arrays with & without back-side metallization for down-converting phonon energy
- Generate QP poisoning from:
 - Direct phonon injection with on-chip tunnel junctions
 - Background radioactivity in lab
 - Active gamma irradiation with ^{60}Co source
- Characterize QP poisoning through:
 - Transient reductions in T_1
 - QP charge-parity switching rate
 - Offset-charge shifts*



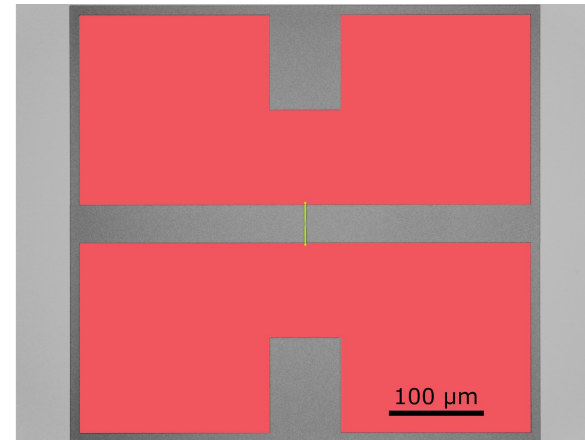
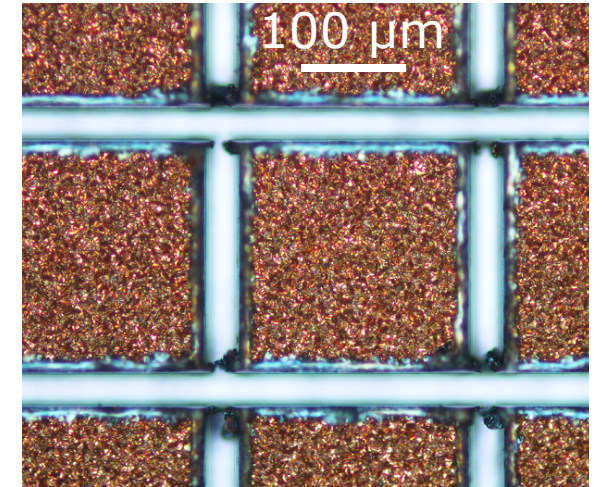
□ Si □ Nb □ Al □ Cu • QP ≡ phonon



Controlled study of phonon-mediated QP poisoning

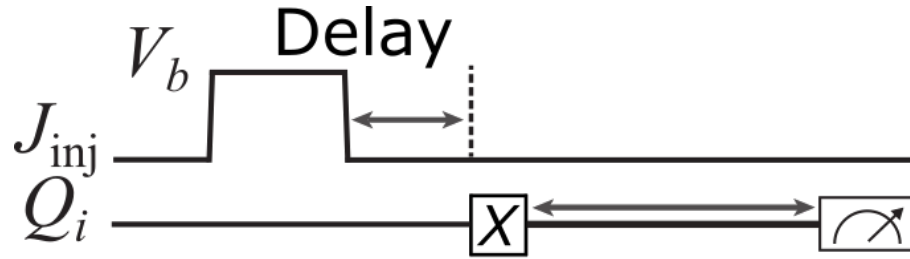


- Nb groundplane
- Al/AlO_x/Al junctions
- Charge-sensitive transmons



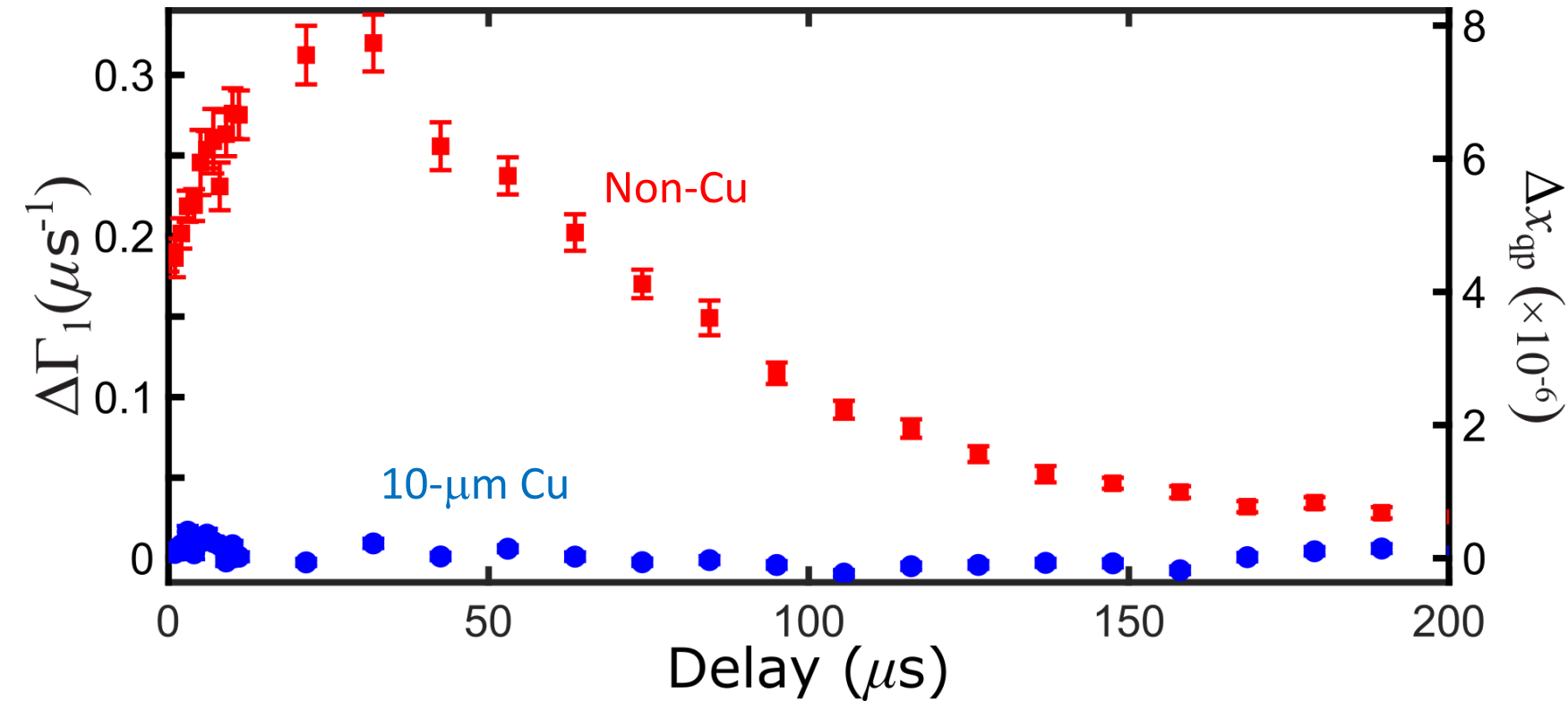
- Electroplated Cu
- Thickness: 1 μm, 10 μm

Enhanced qubit relaxation from controlled phonon injection

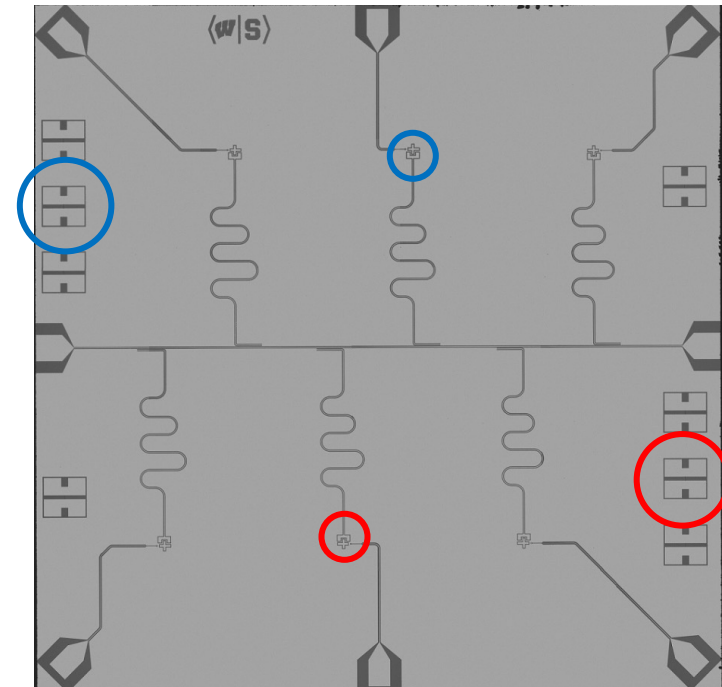


$$\Delta\Gamma_1 = \frac{1}{T_1} - \frac{1}{T_1^b}$$

$$x_{qp} = \frac{\pi}{\sqrt{2\Delta\omega_{01}/\hbar}} \Delta\Gamma_1$$

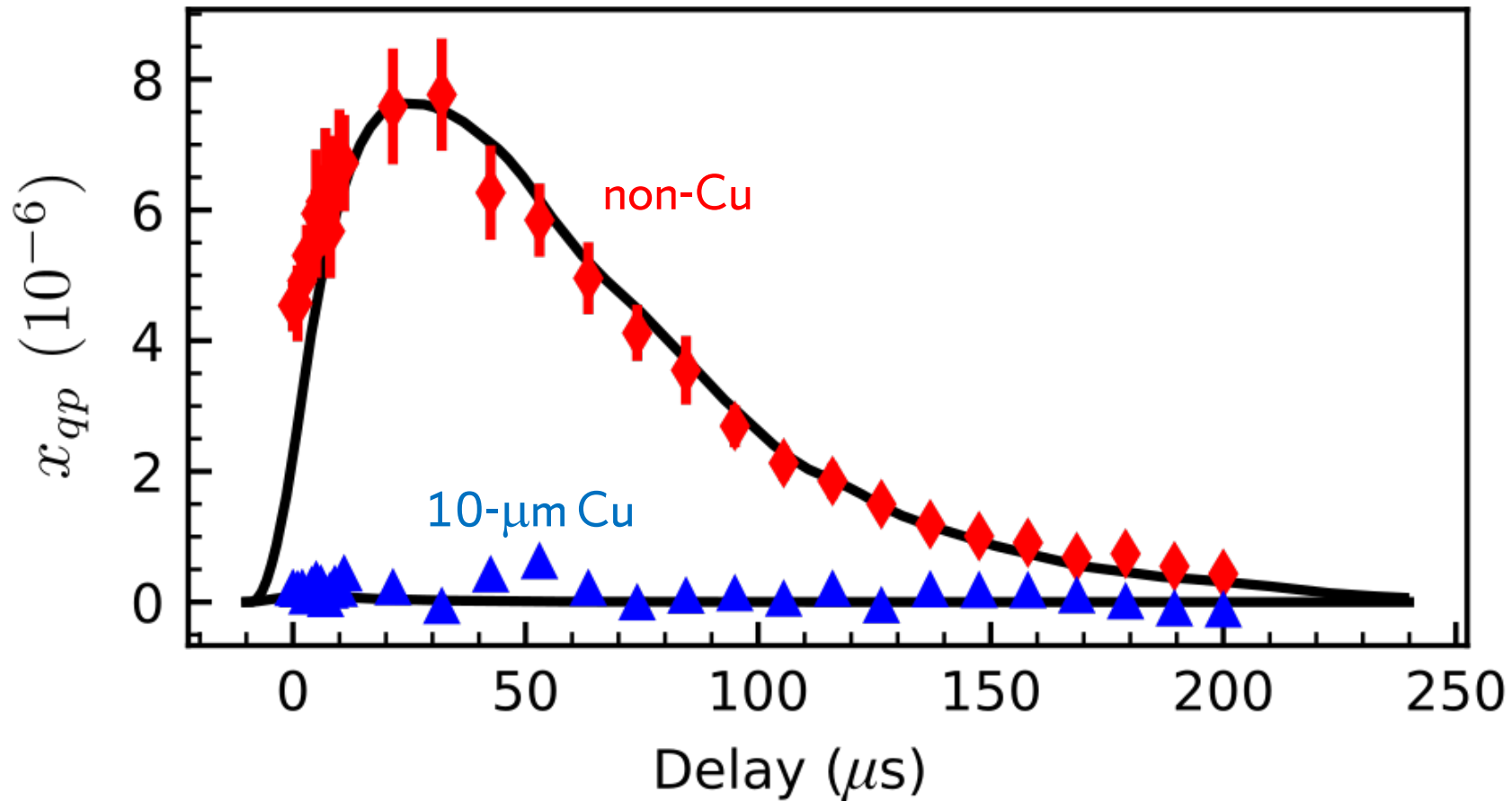


$\Delta\chi_{qp} (\times 10^{-6})$



Modeling and fitting of phonon injection measurements

- Adjust phonon loss probability at chip edges and QP trapping rate for best fit

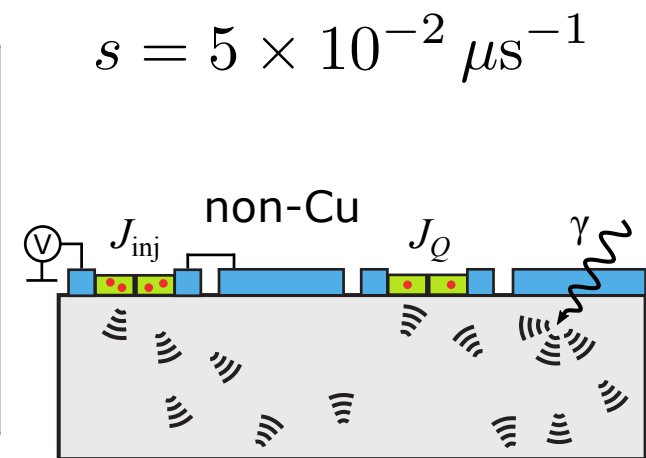
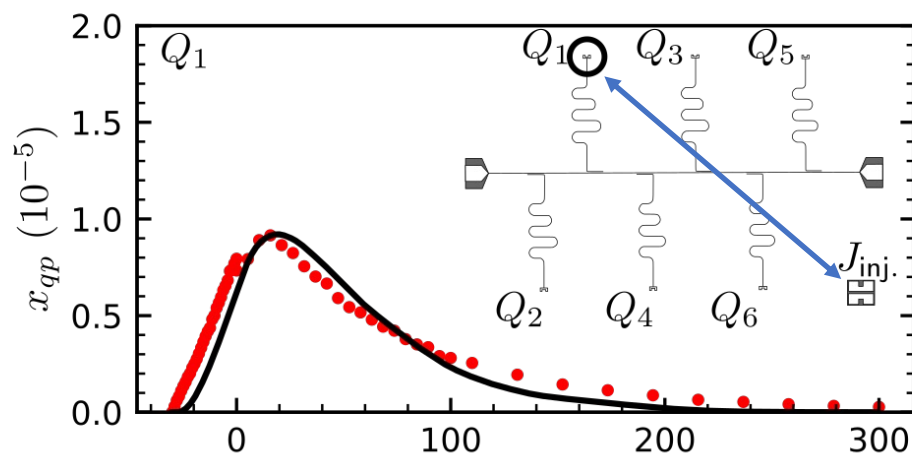
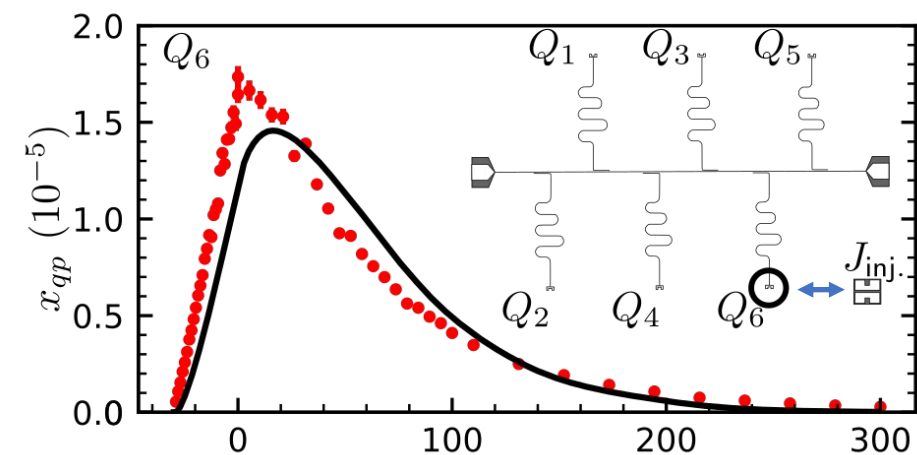


2.5% phonon boundary absorption

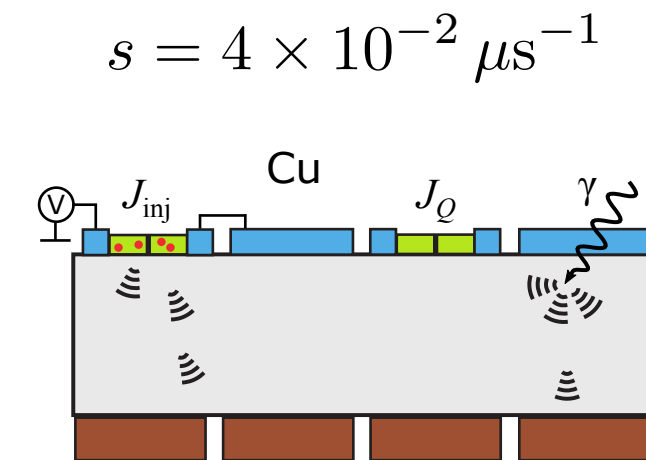
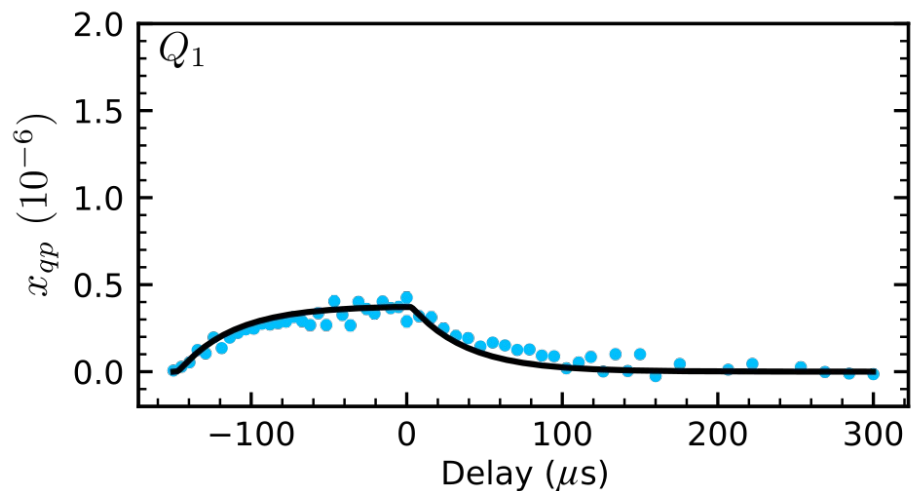
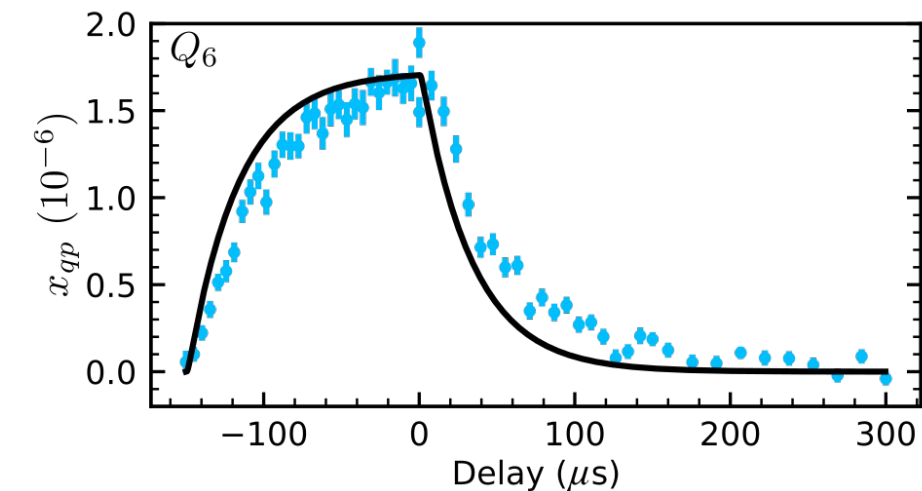
$$s = 4.5 \times 10^{-2} \mu s^{-1}$$

QP poisoning with phonon injection: spatial variation

non-Cu, 30- μ s injection pulse



1- μ m Cu, 150- μ s injection pulse



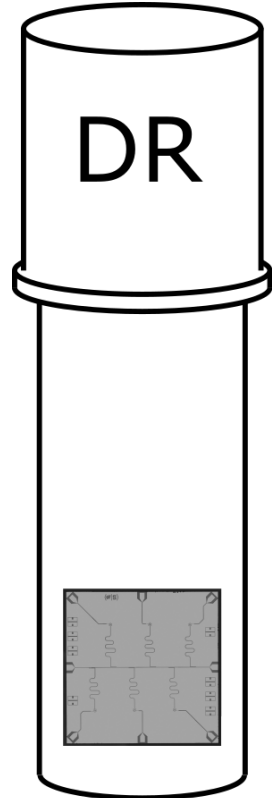
2.5% phonon boundary absorption

Yelton *et al.*, arXiv:2402.15471

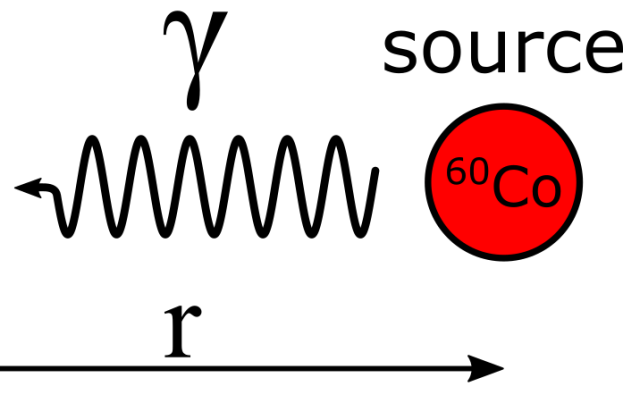
QP poisoning from active γ irradiation

^{60}Co source outside DR

- half life ~ 5 years



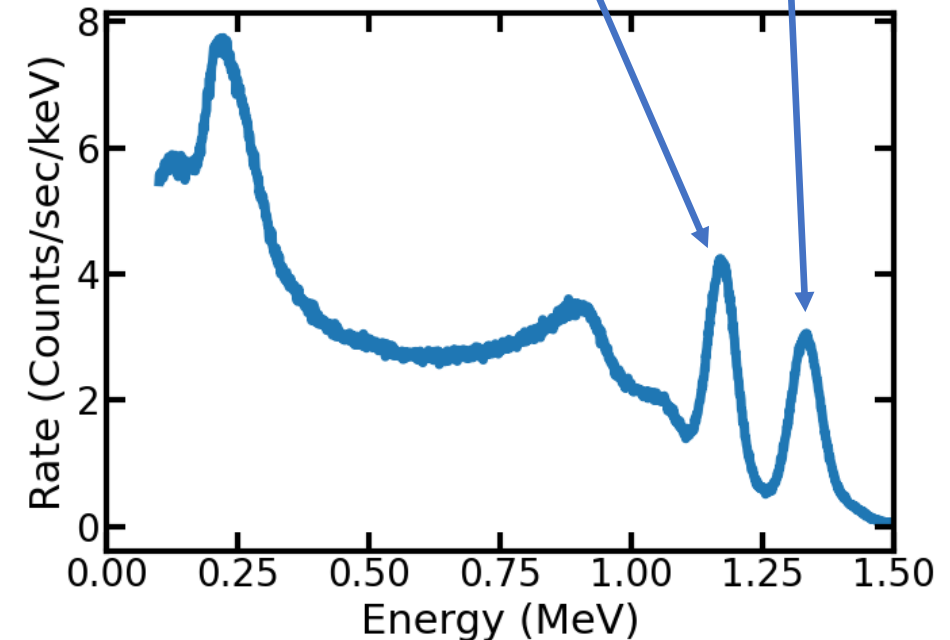
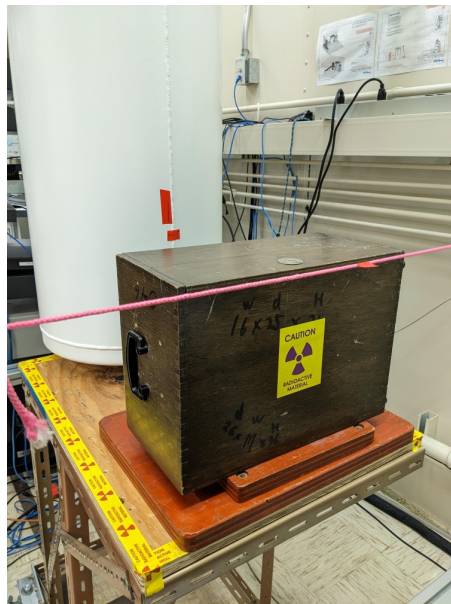
Vary γ dose at sample by adjusting distance



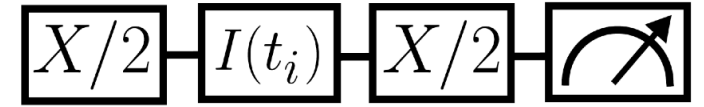
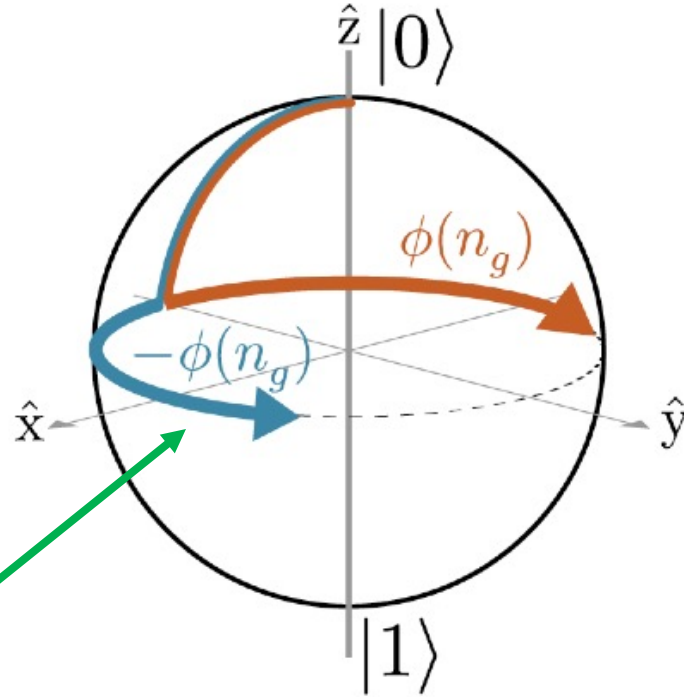
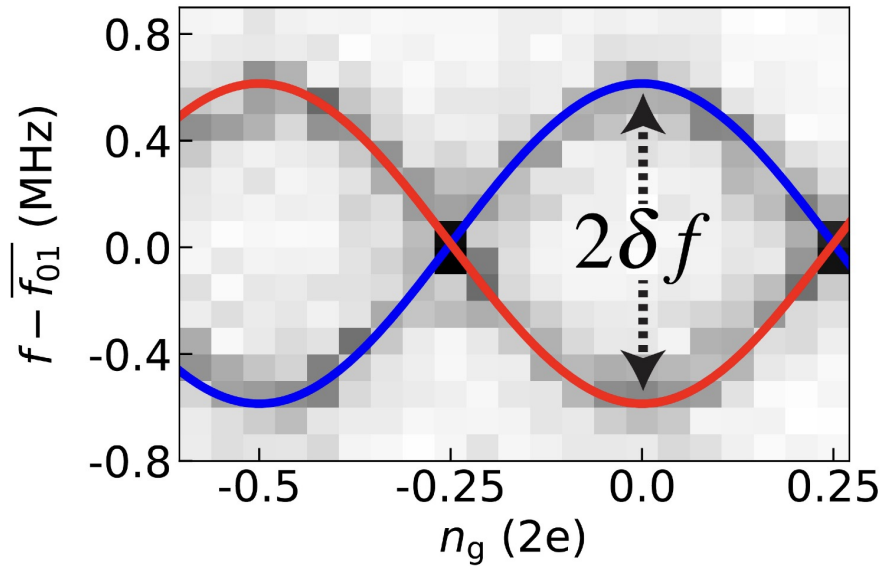
Larson *et al.*, in preparation (2024)



emission of two γ -rays at 1.17 and 1.33 MeV



Monitoring Offset-charge Jumps

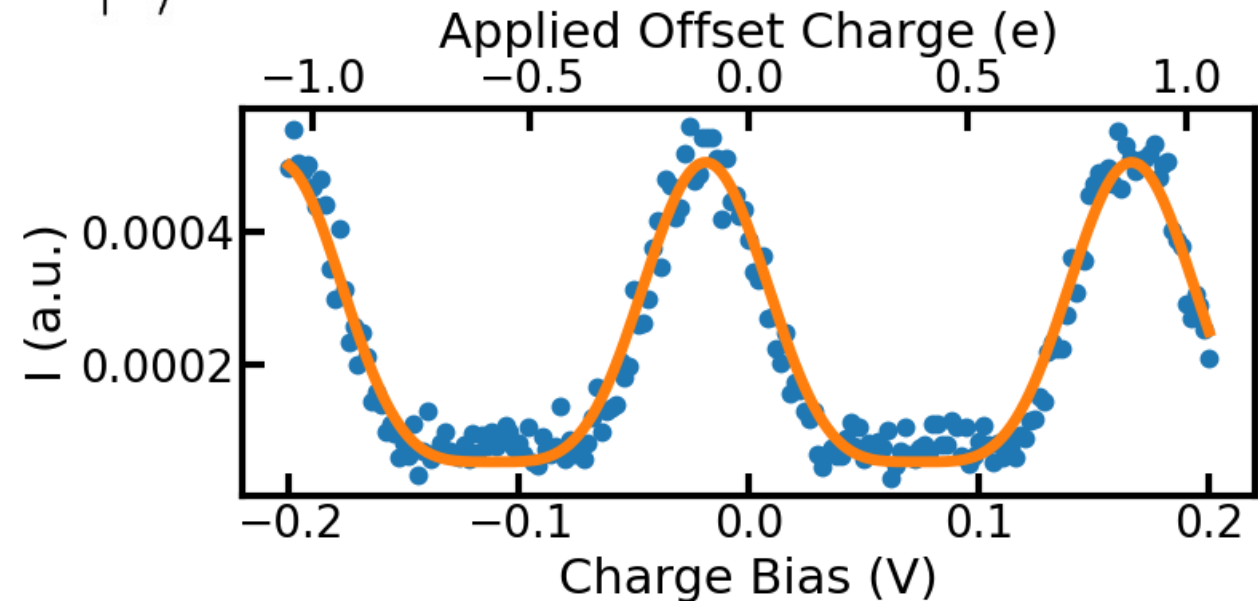


$$t_i = 1/2\delta f$$

Acquisition & fitting time for charge tomography scan ~ 0.2 s

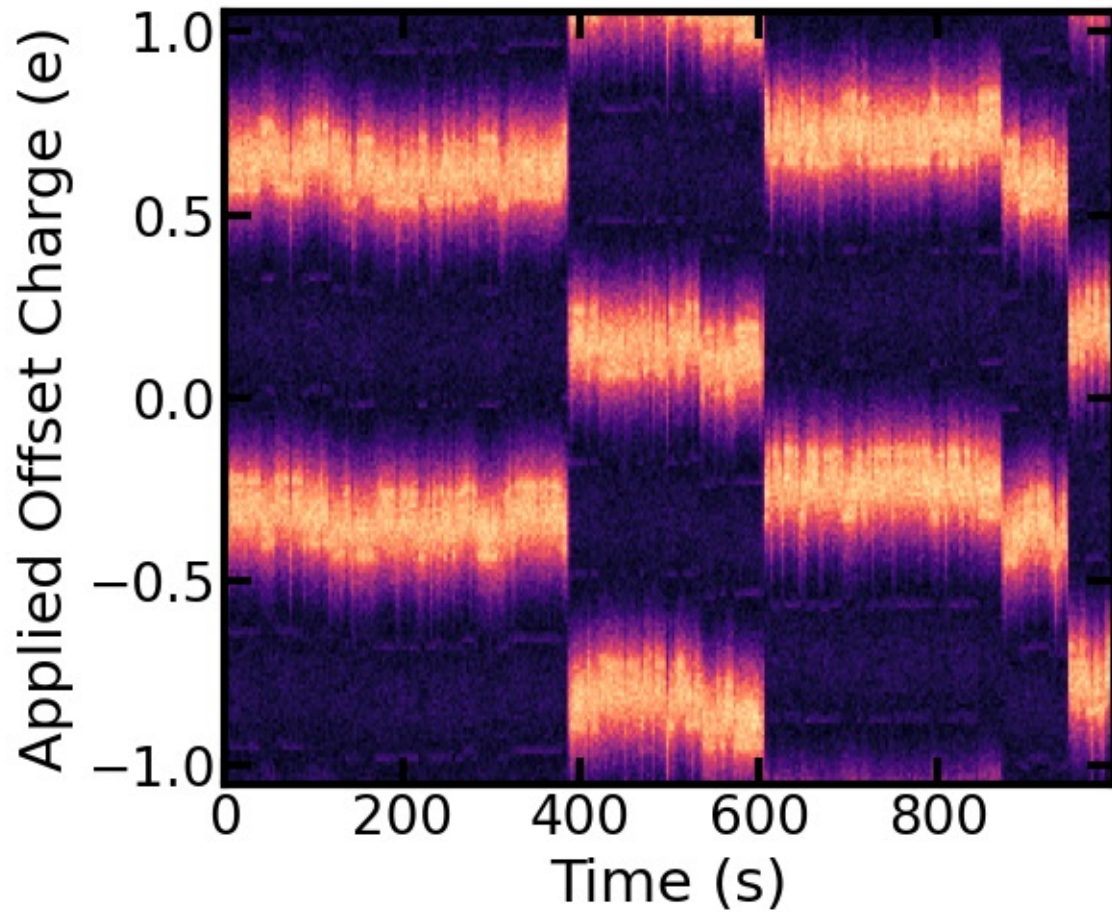
$$\phi(n_g) = t_i \Delta\omega_{10} \cos(2\pi n_g)$$

Christensen *et al.*, Phys. Rev. B **100**, 140503 (2019)



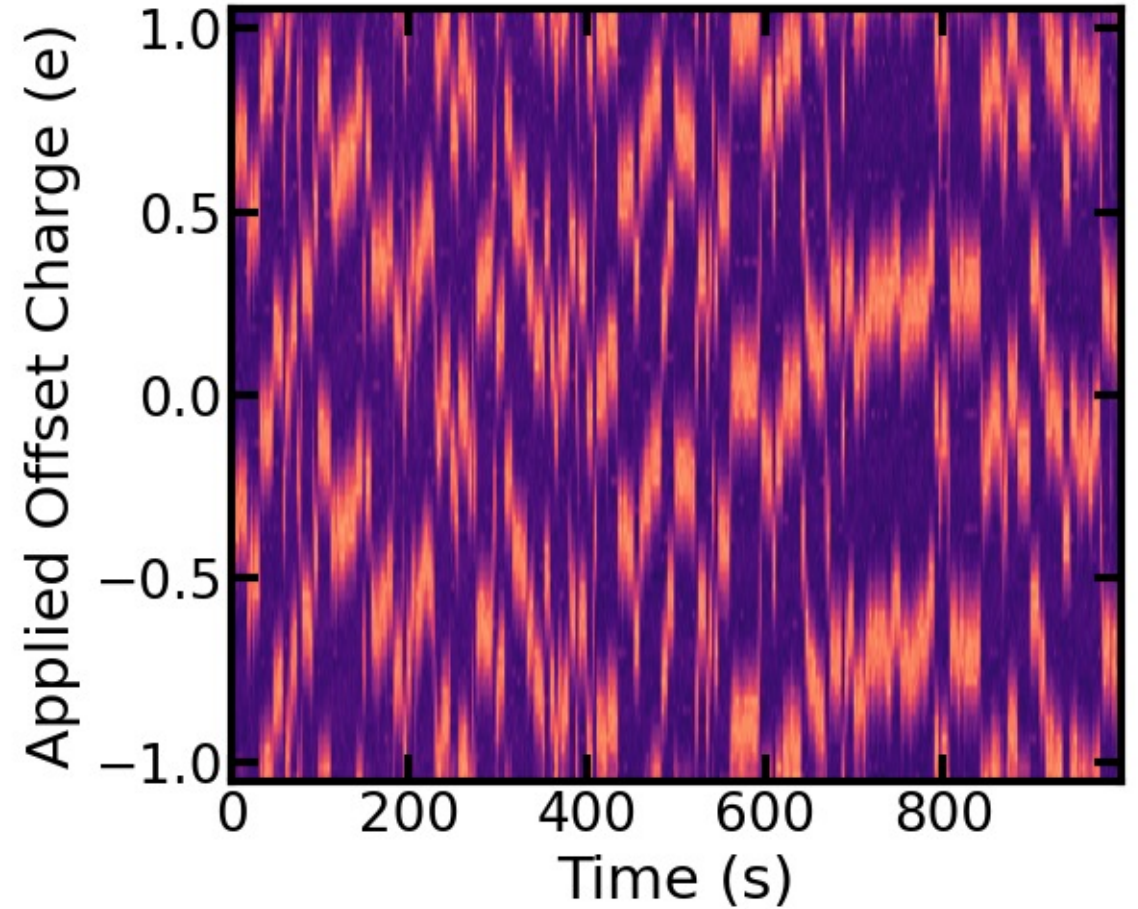
Repeated measurements of offset charge

No ^{60}Co source



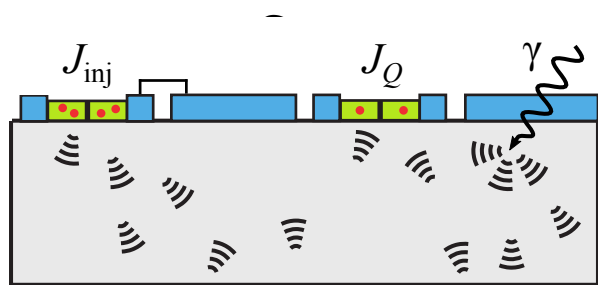
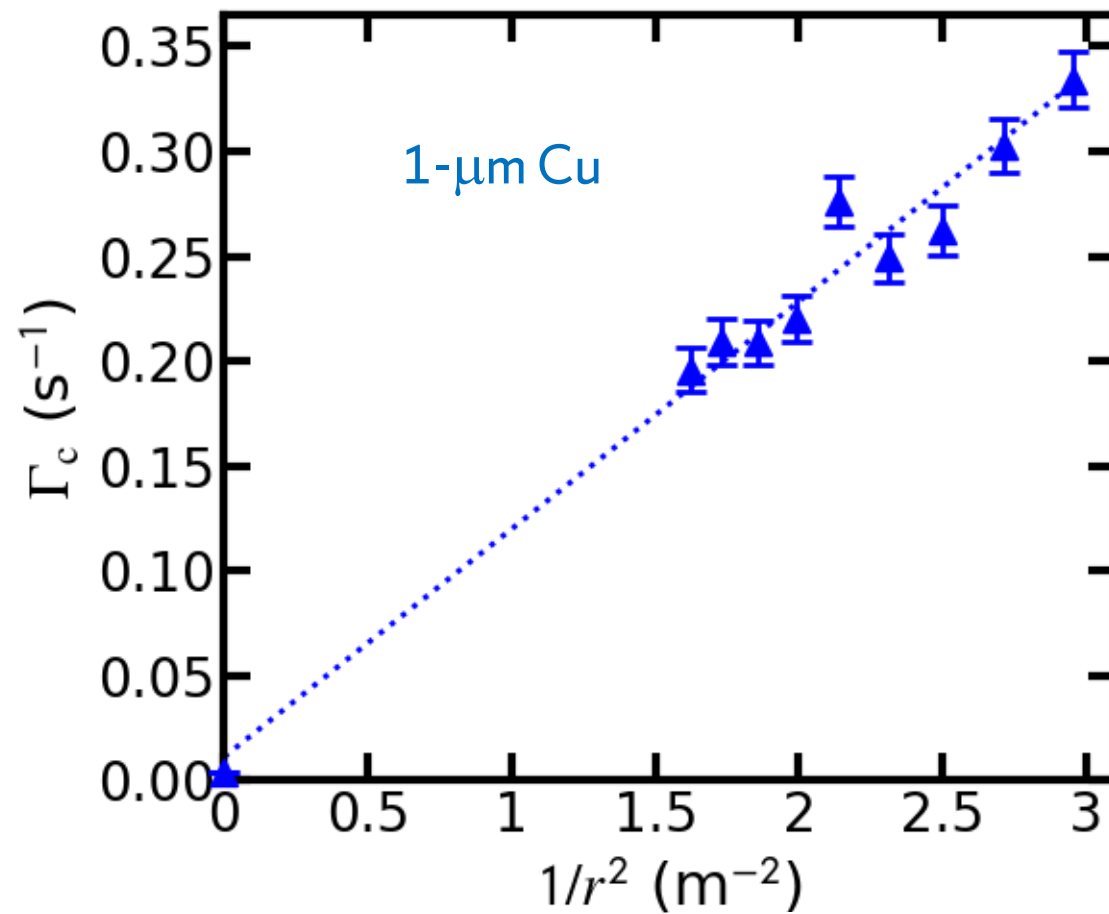
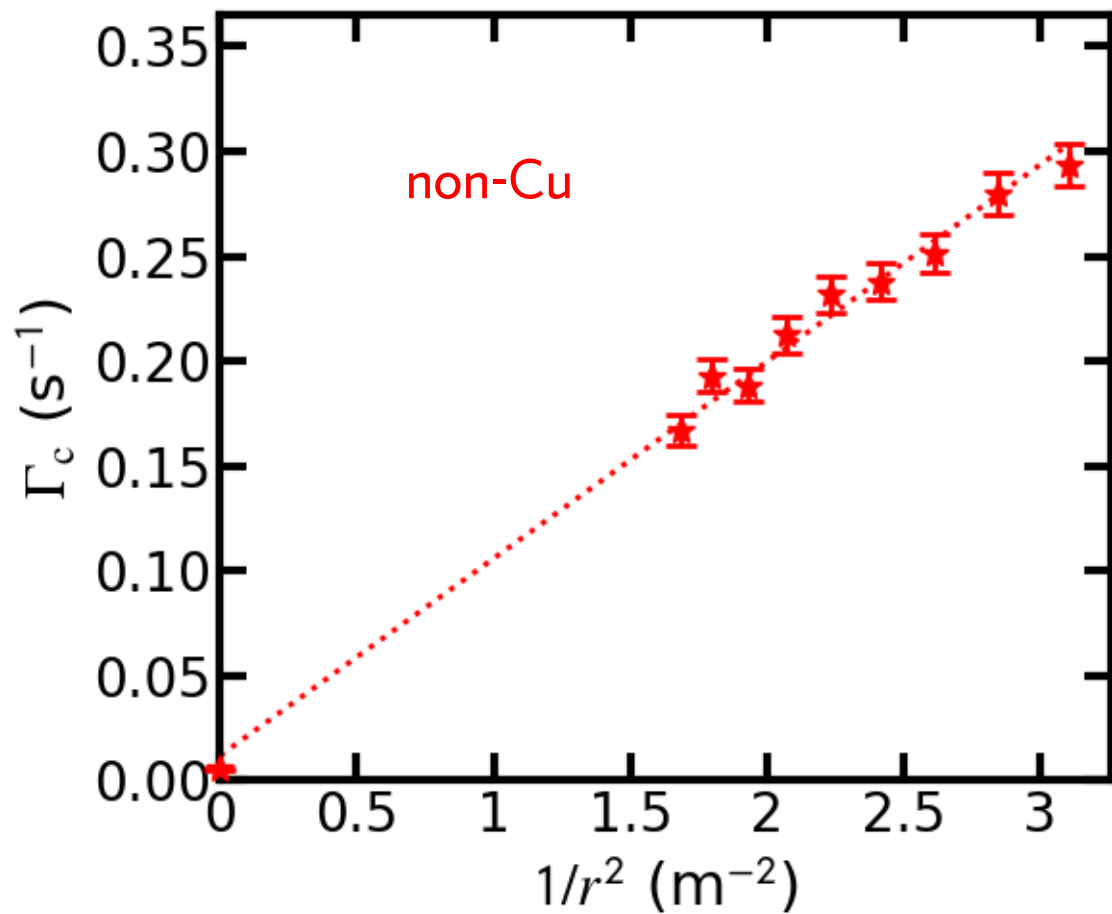
Run charge tomography
scan every 3 s for 1000 s

^{60}Co source at 79 cm

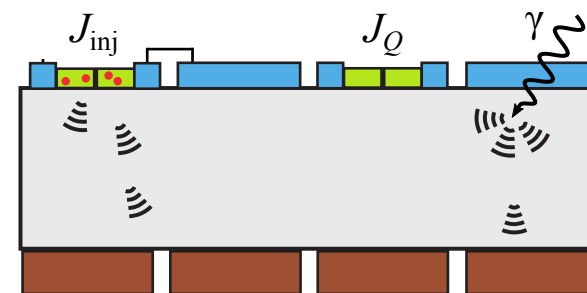


Run charge tomography
scan every 0.2 s for 1000 s

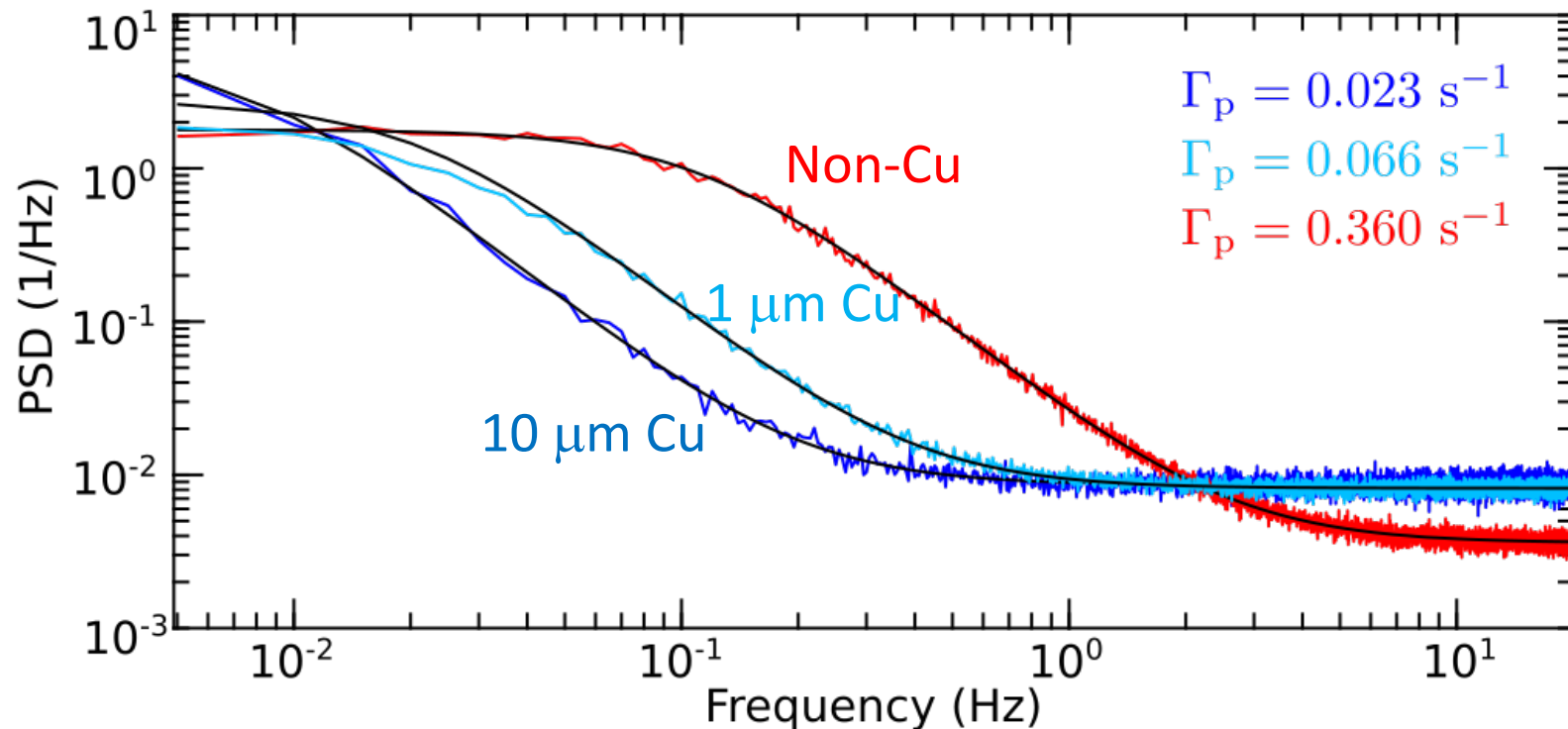
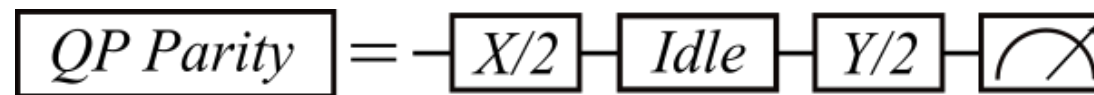
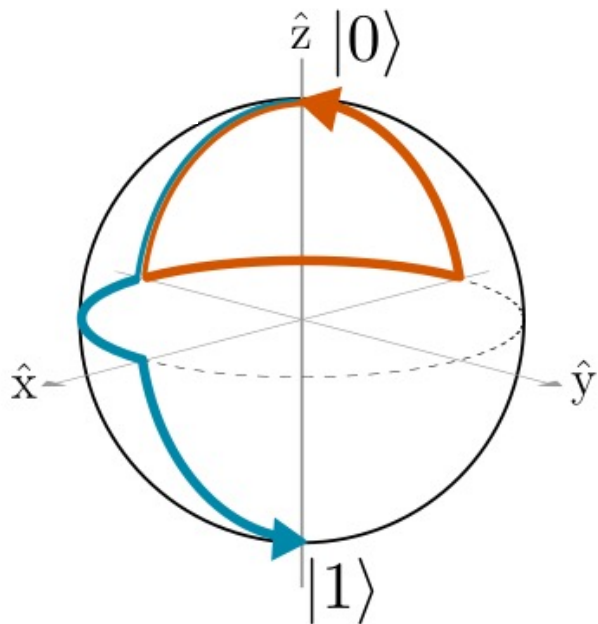
Offset-charge jump rate for different γ doses



Rate of offset-charge jumps comparable for both chips



Direct measurement of QP poisoning via charge parity



Riste *et al.*, Nat. Comm. **4**, 1913 (2013)

$$S_p(f) = \frac{4F^2\Gamma_p}{(2\Gamma_p)^2 + (2\pi f)^2} + (1 - F^2) \Delta t$$

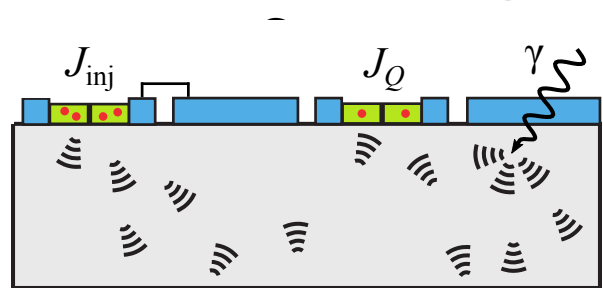
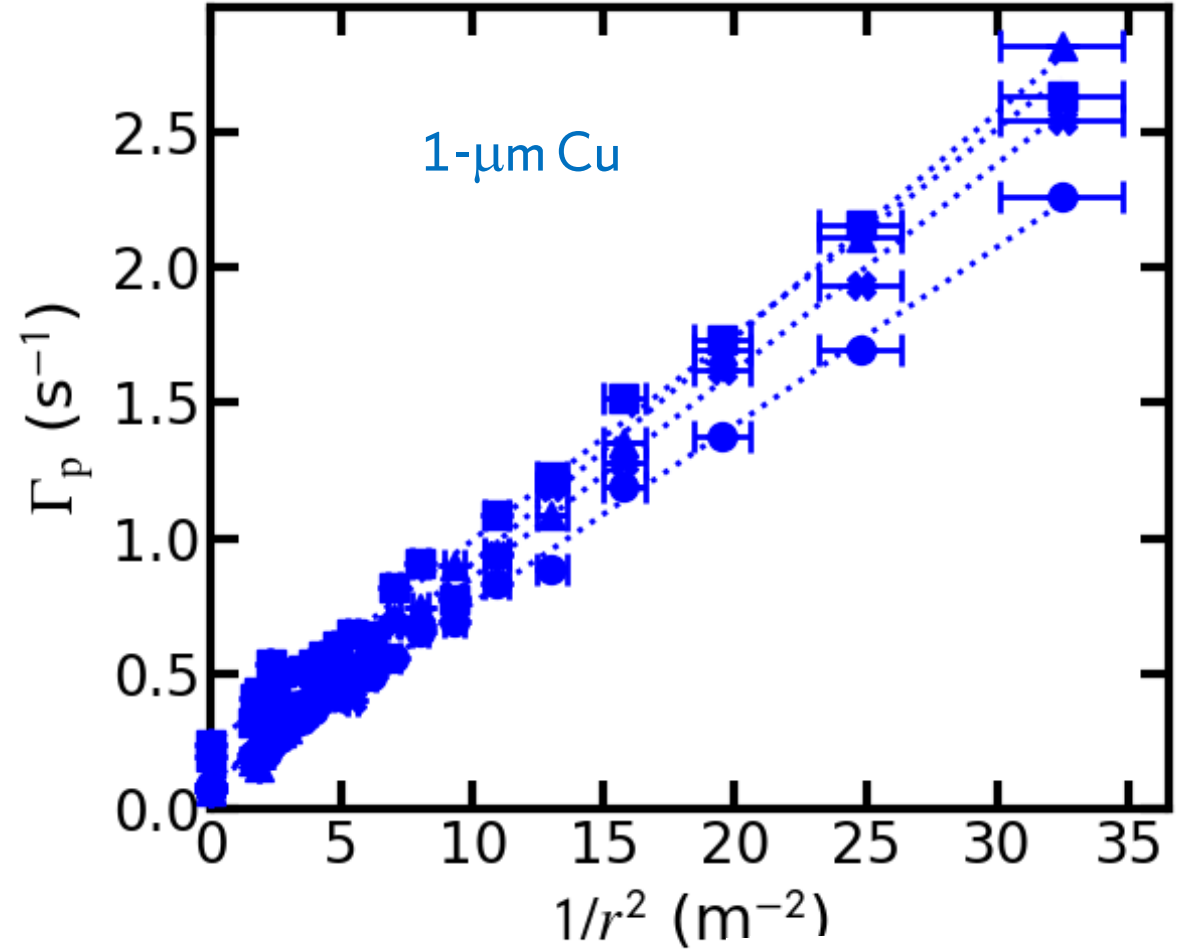
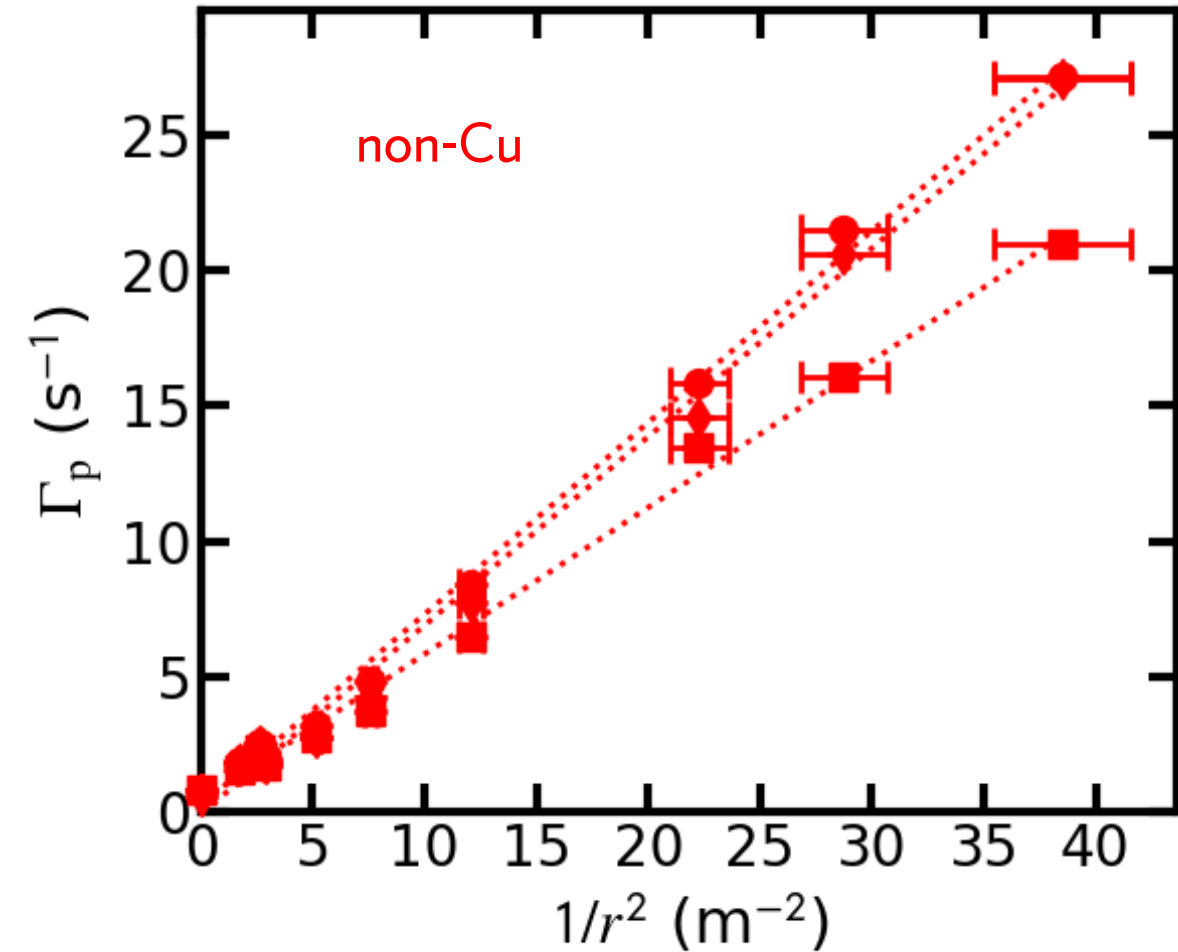
Kurter *et al.*, npj Quantum **8**, 1 (2022)

Pan *et al.*, Nature Comm. **13**, 7196 (2022)

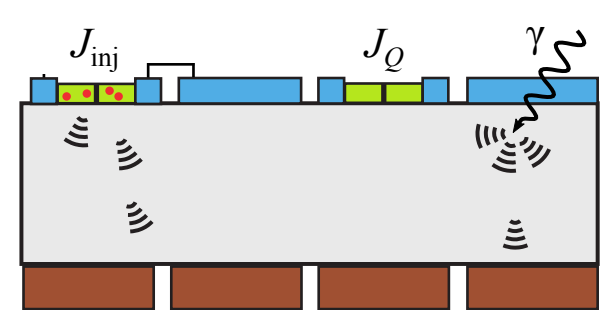
Connolly *et al.*, arXiv:2302.12330

- Low QP parity switching rates
- Effective shielding from stray light and compact qubit footprint

QP charge-parity switching for different γ doses

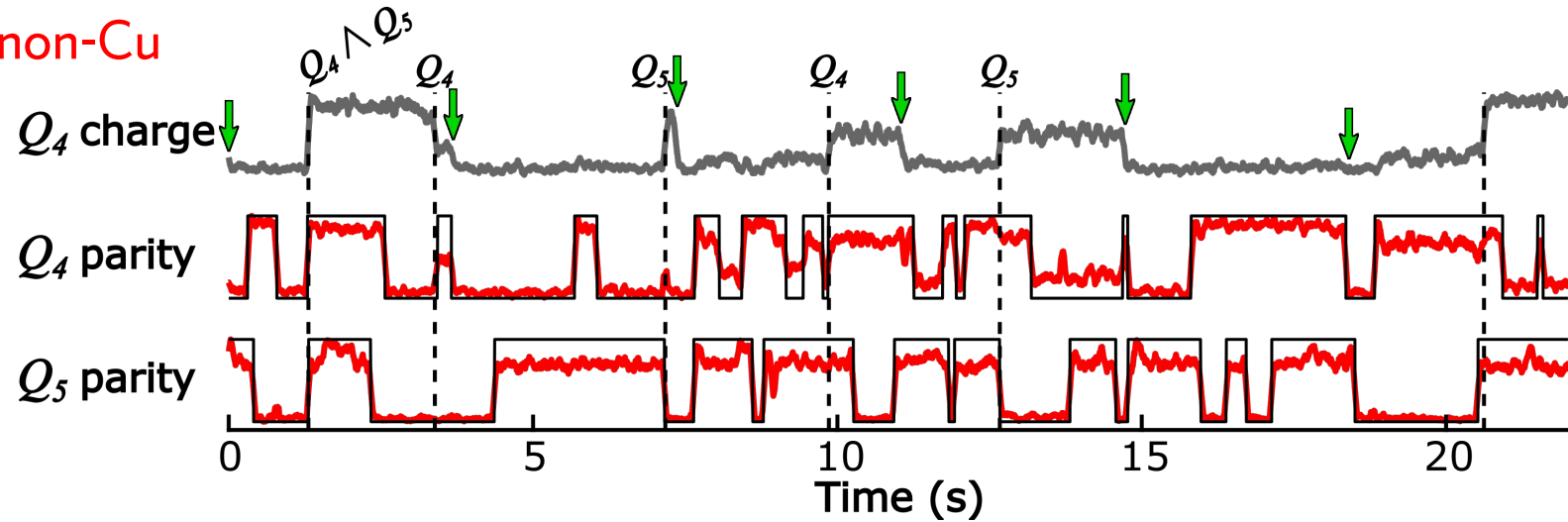


Rate of QP poisoning
~10x higher for device
with no phonon mitigation



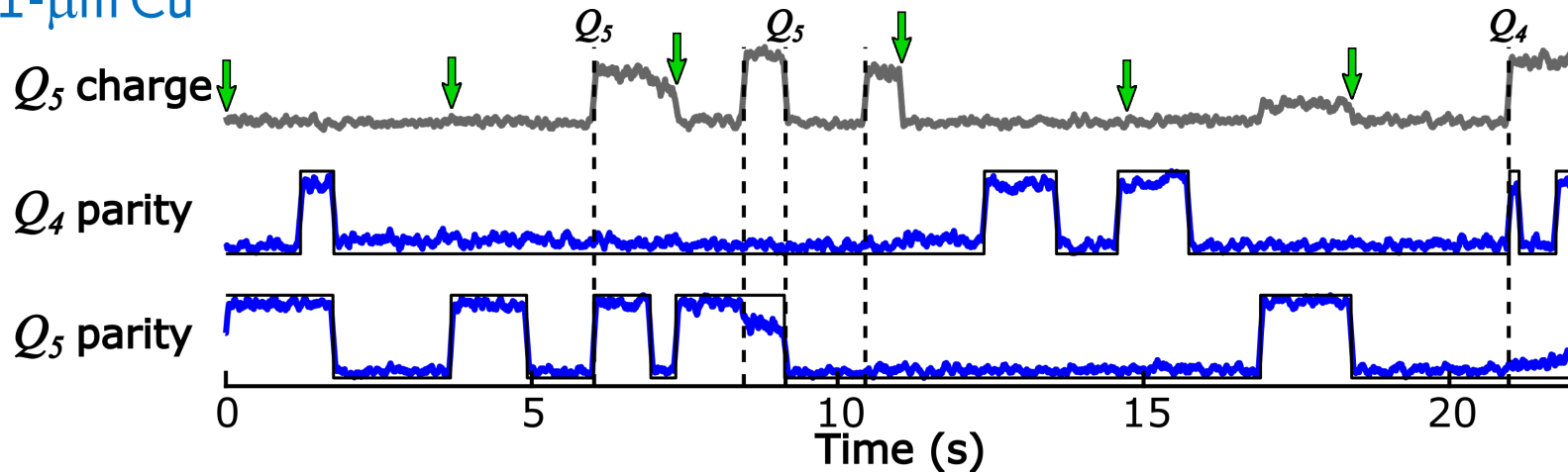
Correlations: offset-charge shifts & QP charge-parity switching (preliminary)

non-Cu

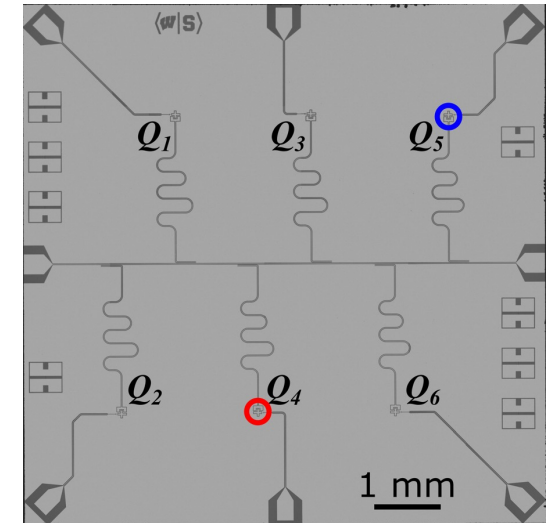


↓ = periodic stabilization of offset charge

1- μ m Cu

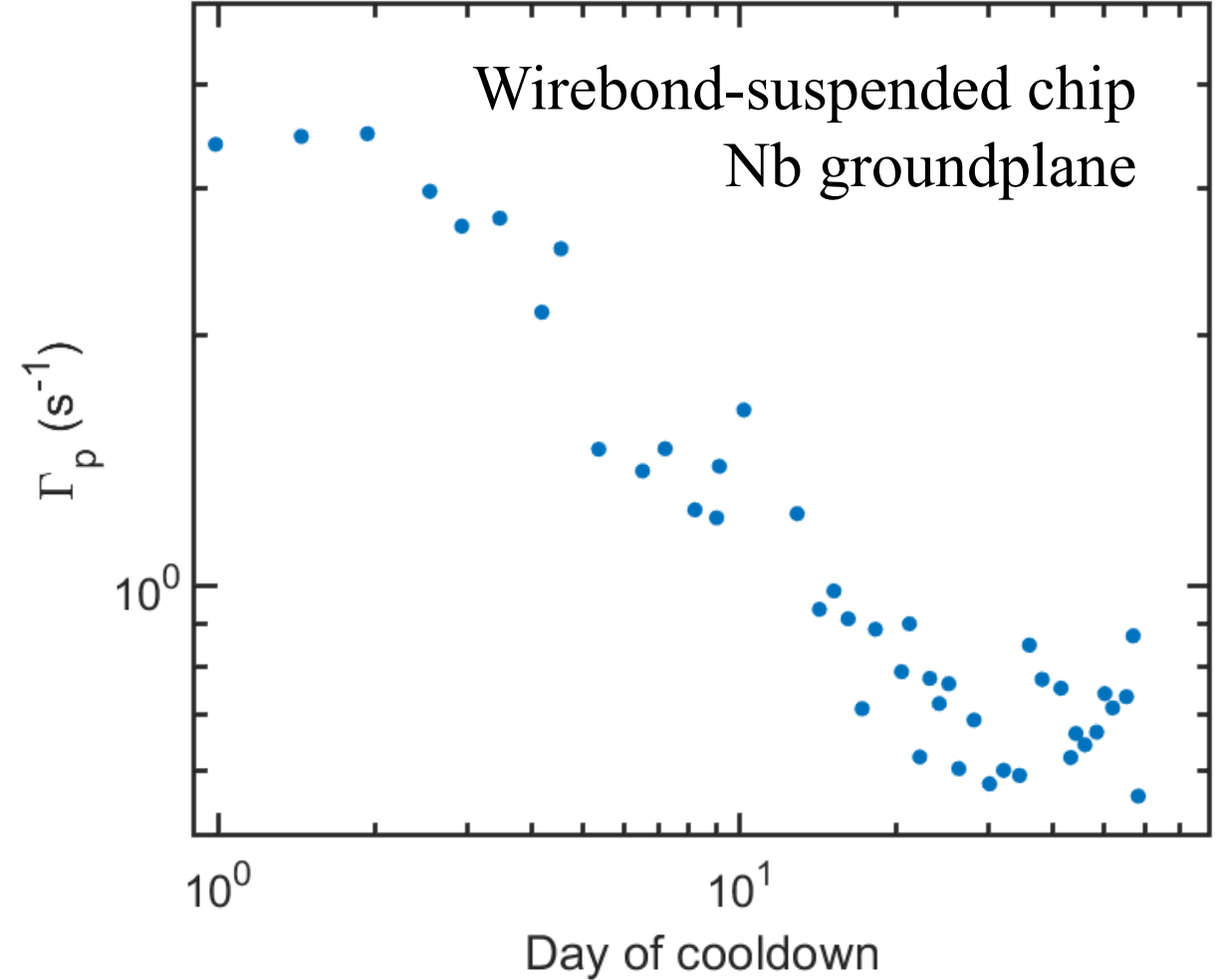
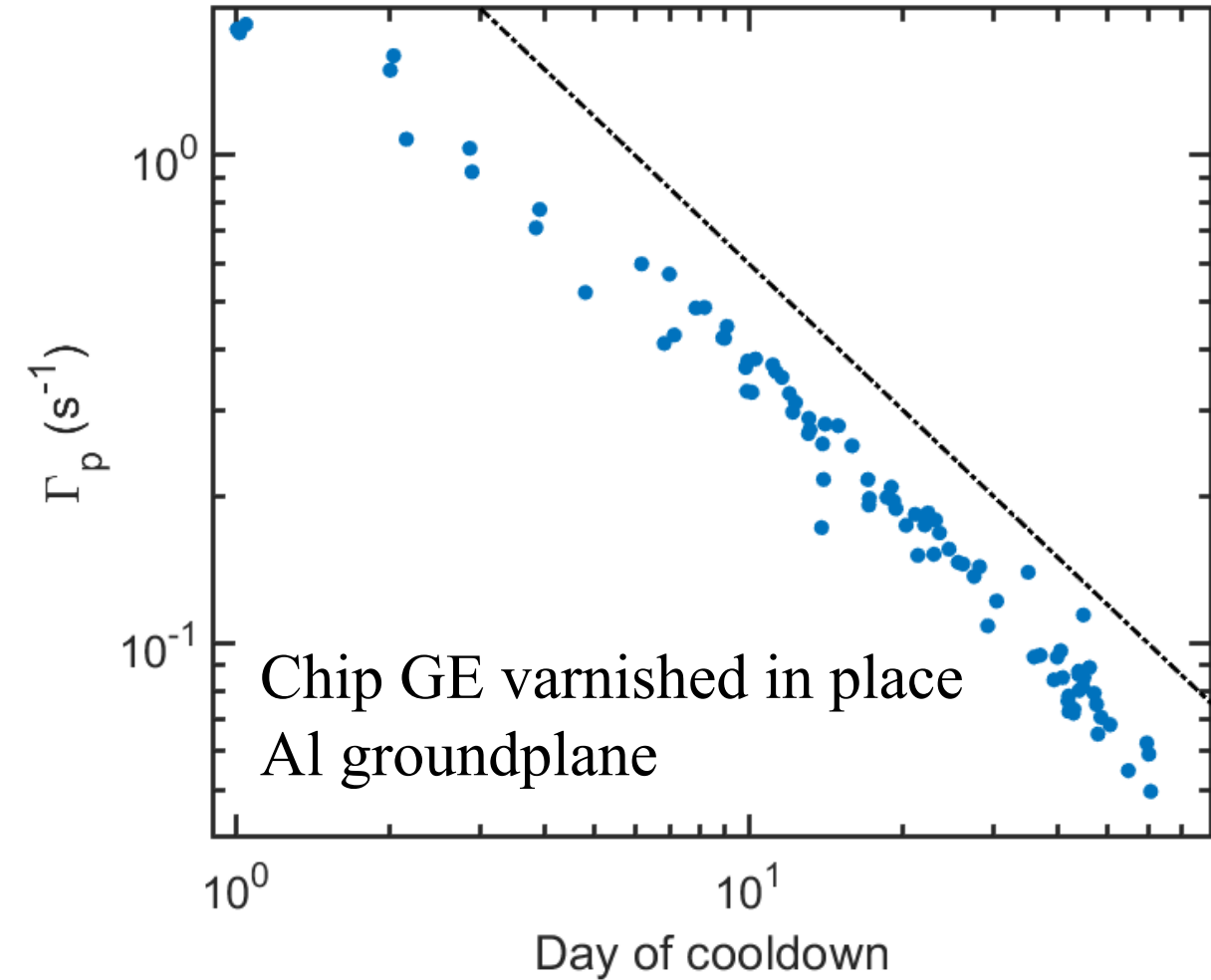


- Strong correlation for QP parity switching & offset charge shift on same qubit
- Significant correlation for all other qubits



- Strong correlation for QP parity switching & offset charge shift on same qubit
- Significant correlation for neighboring qubit but weak for all others

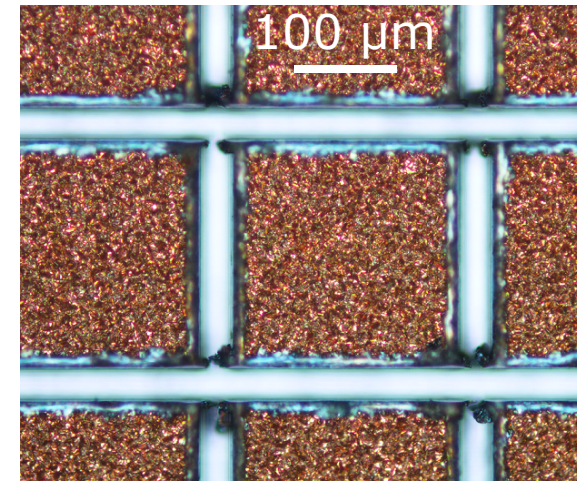
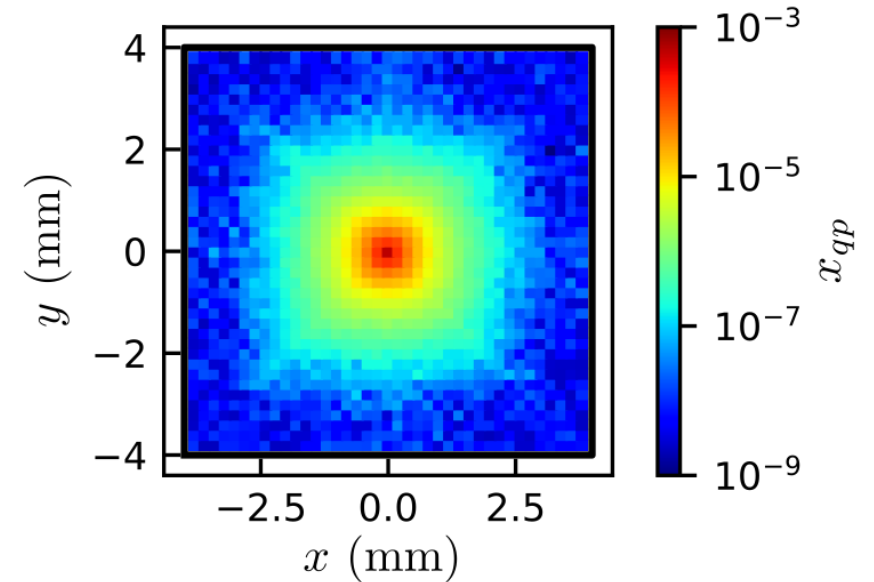
QP parity switching rate versus cooldown time (preliminary)



- Power-law relaxation of stress releases phonon bursts
- Stresses in SC films? Si substrate?

Conclusions & Ongoing Work

- Phonon downconversion in normal metal reservoirs effective for suppressing simultaneous quasiparticle poisoning
- Numerical modeling of phonon and QP dynamics effective for evaluating strategies for mitigating phonon-mediated QP poisoning
- Direct phonon injection with tunnel junctions & active γ irradiation provides direct test of phonon-mediated poisoning
- Correlations between offset-charge shifts and QP parity switching for analyzing poisoning footprint
- Need effective IR shielding for low background QP parity switching rates; study source of power-law phonon-only events



Iaia, Ku *et al.*, Nature
Comm. 13, 6425 (2022)

Yelton *et al.*,
arXiv:2402.15471

Larson *et al.*, in
preparation (2024)

Dodge *et al.*, in
preparation (2024)

Acknowledgments



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